AUG 1 5 2005

(IFW)

Docket No.: 060188-0632 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Wataru ITOH, et al. : Confirmation Number: 3512

Application No.: 10/637,663 : Group Art Unit: 1732

Filed: August 11, 2003 : Examiner: not yet assigned

For: ASSEMBLY FOR LSI TEST AND METHOD FOR THE TEST

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each non-English language reference was first cited in a corresponding foreign application search report or office action and its relevance discussed therein. A copy of the

10/637,663

foreign search report or office action, together with an English language version thereof, is attached for the Examiner's information.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

McDERMOTZ WILL & EMERY LLP

Michael E. Fogarty Registration No. 36,139

600 13th Street, N.W. Washington, DC 20005-3096 Phone: 202.756.8000 MEF:jgh Facsimile: 202.756.8087

Date: August 15, 2005

Please recognize our Customer No. 20277 as our correspondence address.

	TEX.						1	SHEET	<u>1</u> OF <u>1</u>	_	
INFC	CIT	ΆΤ	DISCLOSTION IN AN ICATION	SURE	ATTY. DOCKET NO. 060188-0632	RIAL NO. 0/637,663					
·					APPLICANT Wataru ITOH, et al.						
(PTO-1449)					FILING DATE August 11, 2003						
			U	J.S. PATENT	DOCUMENTS	•		,			
EXAMINER'S INITIALS	CITE NO.	Nui	Document Number mber-Kind Code2 (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applie Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear				
	A1	US	2002/099992	07/25/2002	Distler et al.					_	
		US									
		US								_	
	 	us					-	-			
		us	<u></u>				-				
		US									
		US									
		US									
		US					 				
	 	US									
		US									
		US									
FOREIGN PATENT DOCUMENTS											
EXAMINER'S INITIALS CITE NO.		Foreign Patent Document Country Codes -Number 4 -Kind Codes (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Where f	Pages, Columns, Lines Where Relevant Figures Appear		Translation 'es No		
	A2	WO 02/29824		04/11/2002	Concord Idea Corp.						
		JP 4-155278 with English abstract		05/28/1992	NEC Corp.						
,	 	├				 					
-	 	 		 	-					—	
	<u> </u>										
		<u></u>	OTHER A	RT (Including Autho	r, Title, Date, Pertinent Pages, E	tc.)					
EXAMINER'S INITIALS	CITE NO.	journ			i), title of the article (when apprope(s), volume-issue number(s), p				Э,		
		ļ		- ·							
	 										
FYAMINER						DATE CONS	INEREN				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.